

Search Notes**Application/Control No.**

10/644,850

Examiner

Pritham Prabhakher

Applicant(s)/Patent under Reexamination

SHINOHARA, MAHITO

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	281	1/23/2007	PP
250	208.1	1/23/2007	PP
348	308	1/23/2007	PP
257	292	1/23/2007	PP
348	302	1/23/2007	PP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
On East [US-PGPUB, USPA, USOCR, EPO, JPO, DERWENT, IBM_TDB] SEE SEARCH TERMS ATTACHED]	1/27/2007	PP
Inventor Name Search	1/26/2007	PP
Google Search Terms [JFET and MOSFET]	1/23/2007	PP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner